

Approaches to improve hierarchical ATPG for synchronous sequential circuits

Viilukas, Taavi Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK kuuenda aastakonverentsi artiklite kogumik : 3.-5. oktoobril 2012, Laulasmaa 2012 / p. 105-108 : ill

Assembling low-level tests to high-level symbolic test frames

Jervan, Gert; Markus, Antti; Raik, Jaan; Ubar, Raimund-Johannes Proceedings [of the] 15th NORCHIP Conference, Tallinn, 10-11 November 1997 1997 / p. 275-280: ill

Assessment of river waters and waste waters toxicity using battery of toxicity tests

Blinova, Irina Joint Conference of Scandinavian Society of Cell Toxicology and Estonian Society of Toxicology : (SSCT & ETS 98) : Tallinn, October 23-26, 1998 : program and abstracts 1998 / l. 60

Aufstellung von Testfolgen für logische Schaltungen

Plakk, Mari; Ubar, Raimund-Johannes Internationales wissenschaftliches Kolloquium 1979 / S. 93-96
https://www.ester.ee/record=b2936968*est

Aus der Testpraxis beim Kommunikativorientierten Fremdsprachenunterricht

Lobatsch, E.; Mojssejtschuk, A. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 64-66

Automated test pattern generator with constraint solver

Viilukas, Taavi; Raik, Jaan Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK neljanda aastakonverentsi artiklite kogumik : 26.-27. novembril 2010, Essu mõis 2010 / lk. 33-36

Automatic test generation system for VLSI

Jervan, Gert; Markus, Antti; Raik, Jaan; Ubar, Raimund-Johannes Proceedings of the First Electronic Circuits and Systems Conference : Bratislava, Slovakia, September 4-5, 1997 1997 / p. 255-258

Biotests and biosensors in ecotoxicological risk assessment of field soils polluted with zinc, lead, and cadmium

Kahru, Anne; Ivask, Angela; Kasemets, Kaja; Põllumaa, Lee; Kurvet, Imbi; Francois, Matthieu; Dubourguier, Henri-Charles Environmental toxicology and chemistry 2005 / 11, p. 2973-2982

CAD software for digital test and diagnostics

Jervan, Gert; Markus, Antti; Paomets, Priidu; Raik, Jaan; Ubar, Raimund-Johannes Proceedings of International Conference on Design and Diagnostics of Electronic Circuits and Systems, Ostrava, Czech Republik, May 12-14, 1997 1997 / p. 35-40

A CAD system for teaching digital test

Ubar, Raimund-Johannes; Ivask, Eero; Paomets, Priidu; Raik, Jaan BEC : Baltic Electronics Conference : proceedings of the 4th Biennial Conference, October 9-14, 1994, Tallinn (Estonia). 1 1994 / p. 369-372: ill

CNN based analysis of the Luria's alternating series test for Parkinson's disease diagnostics

Zaremba, Sergei; Nõmm, Sven; Medijainen, Kadri; Taba, Pille; Toomela, Aaro Recent Challenges in Intelligent Information and Database Systems : 13th Asian Conference, ACIIIDS 2021, Phuket, Thailand, April 7-10, 2021 : proceedings 2021 / p. 3-13

https://doi.org/10.1007/978-981-16-1685-3_1 Conference Proceedings at Scopus Article at Scopus

Combining functional and structural approaches in test generation for digital systems

Ubar, Raimund-Johannes Microelectronics reliability 1998 / p. 317-329 : ill [https://doi.org/10.1016/S0026-2714\(97\)00192-3](https://doi.org/10.1016/S0026-2714(97)00192-3)

Combining symbolic techniques with topological approach in test generation

Ubar, Raimund-Johannes Proceedings of the 3rd Workshop on Mixed Design of Integrated Circuits and Systems, Lodz, May 1996 1996 / p. 377-382

A comprehensive stepped planing hull systematic series : part 1 - resistance test

Vitiello, Luigi; Mancini, Simone; **Niazmand Bilandi, Rasul**; Dashtimanesh, Abbas; De Luca, Fabio; Nappo, Vincenzo Ocean engineering 2022 / art. 112242 <https://doi.org/10.1016/j.oceaneng.2022.112242> Journal metrics at Scopus Article at Scopus Journal metrics at WOS Article at WOS

Constraint-based hierarchical untestability identification for synchronous sequential circuits

Raik, Jaan; Rannaste, Anna; Jenihhin, Maksim; Viilukas, Taavi; Ubar, Raimund-Johannes; Fujiwara, Hideo Sixteenth IEEE European Test Symposium : 23-27 May 2011, Trondheim 2011 / p. 147-152

Constraint-based hierarchical untestability identification for synchronous sequential circuits

Viilukas, Taavi; Raik, Jaan; Ubar, Raimund-Johannes; Rannaste, Anna; Jenihhin, Maksim; Fujiwara, Hideo Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK viienda aastakonverentsi artiklite kogumik : 25.-26. novembril 2011, Nelijärve 2011 / p. 139-142 : ill

Constraints analysis in hierarchical test generation for digital systems

Ubar, Raimund-Johannes; Krupnova, Helena BEC : Baltic Electronics Conference : proceedings of the 4th Biennial Conference, October 9-14, 1994, Tallinn (Estonia). 1 1994 / p. 313-318: ill

Constraints solving based hierarchical test generation for synchronous sequential circuits = Kitsenduste lahendamisel baseeruv hierarhiline testigeneerimine sünkroonsetele järjestikskeemidele

Viilukas, Taavi 2012 https://www.ester.ee/record=b2888278*est

Correlation between COVID-19 cases and gold price fluctuation

Gautam, Roshan; Kim, Yoochan; Topal, Erkan; **Hitch, Michael William** International journal of mining, reclamation and environment 2022 / p. 574-586 <https://doi.org/10.1080/17480930.2022.2077542>

CPT, CPTu and DCPT methods for predicting the ultimate bearing capacity of cast in situ displacement piles in silty soils

Leetsaar, Lehar; Korkiala-Tanttu, Leena; **Kurnitski, Jarek** Geotechnical and Geological Engineering 2022 / p. 631-652 : ill

<https://doi.org/10.1007/s10706-022-02292-6> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Defect oriented fault coverage of 100stuck-at fault test sets

Blyzniuk, M.; Cibakova, Tatiana; Gramatova, Elena; Kuzmicz, W.; Lobur, M.; Pleskacz, Witold A.; **Raik, Jaan; Ubar, Raimund-Johannes** Proceedings of the 7th International Conference Mixed Design of Integrated Circuits and Systems : MIXDES 2000 : Gdynia, Poland, 15-17 June 2000 2000 / p. 511-516 : ill <https://repo.pw.edu.pl/info/seam?ps=20&id=WUT7e20f35d67ae45d3b2d1264d7a4ba722&en&pn=1&cid=156607>

Defect-oriented library builder and hierarchical test generation

Cibakova, Tatiana; Gramatova, Elena; Kuzmicz, W.; Pleskacz, Witold A.; **Raik, Jaan; Ubar, Raimund-Johannes** IEEE Design and Diagnostics of Electronic Circuits and Systems - IEEE DDECS 2001 : Fourth International Workshop on IEEE Design and Diagnostics of Electronic Circuits and Systems : Győr, Hungary, April 18-20, 2001 2001 / p. 163-168 : ill

Dense components in the structure of WordNet

Lohk, Ahti; Orav, Heili; **Allik, Kaarel; Vöhandu, Leo** Proceedings of the Ninth International Conference on Language Resources and Evaluation (LREC'14) : May 26-31, 2014, Reykjavik, Iceland 2014 / p. 1135-1139 : ill

Design error localization in digital circuits by stuck-at fault test patterns

Jutman, Artur; Ubar, Raimund-Johannes [MIEL] 2000 : 22nd International Conference on Microelectronics : Niš, Yugoslavia, 14-17 May 2000 : proceedings. Volume 2 2000 / p. 723-726 <https://ieeexplore.ieee.org/document/838792>

Design of a digitally controlled resistance and capacitance device for testing of the bio-impedance measurement systems

Birjukov, Andrei Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK teise aastakonverentsi artiklite kogumik : 11.-12. mai 2007, Viinistu kunstimuuseum 2007 / lk. 149-152 : ill

Design of sustainable ionic liquids based on l-phenylalanine and l-alanine dipeptides : synthesis, toxicity and biodegradation studies

Kapitanov, Illia; Raba, Grete; Špulak, Marcel; **Vilu, Raivo; Karpichev, Yevgen; Gathergood, Nicholas** Journal of Molecular Liquids 2023 / art. 121285 <https://doi.org/10.1016/j.molliq.2023.121285> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Determining necessary length of the alternating series test for Parkinson's disease modelling

Nömm, Sven; Kossas, Tanel; Toomela, Aaro; Medijainen, Kadri; Taba, Pille 2019 International Conference on Cyberworlds : CW 2019 : 2-4 October 2019, Kyoto, Japan : proceedings 2019 / p. 261-266 : ill <http://doi.org/10.1109/CW.2019.00050>

Development of a portable MIP-based electrochemical sensor for detection of SARS-CoV-2 antigen

Raziq, Abdul; Kidakova, Anna; Boroznjak, Roman; Reut, Jekaterina; Öpik, Andres; Söritski, Vitali Biosensors and bioelectronics 2021 / art. 113029 <https://doi.org/10.1016/j.bios.2021.113029> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Die Anwendung der Tests im intensiven Fremdsprachenunterricht

Ivanova, O.; Grigorjeva, L. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 51-52

Die Anwendung von Tests im Fernstudium an technischen Universitäten

Umborg, Viktoria V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 104-107

Difficulty of cloze test modifications

Kokkota, Valmar 2nd regional seminar Testing in foreign language teaching : Tallinn, February 25-26, 1986 : summaries 1986 / p. 51-53 https://www.ester.ee/record=b1217950*est

Digital design learning system based on Java applets

Jutman, Artur; Sudnitsõn, Aleksander; Ubar, Raimund-Johannes 4th Annual Conference of the LTSN Centre for Information and Computer Sciences : 26th-28th August 2002, NUI Galway, Ireland 2003 / p. 183-187 : ill <https://pld.ttu.ee/diidis/publications/Sudnitsõn%20LTSN-ICS%202003.pdf>

Digital test in WEB-based environment

Ivask, Eero 2006 https://www.ester.ee/record=b2158119*est

Eesti teadlaste leiutis: uus koroonaviiruse kiirtest ootab heakskiitu ja otsib tootjat

Ladva, Asso Õhtuleht 2020 / Lk. 5 <https://dea.digar.ee/article/ohtuleht/2020/12/07/2.12>

Eesti-Saksa ettevõtte arendas laboritäpsusega koroonakiirtesti

Eesti Elu : [Kanada ajaleht] 2020 / lk. 3 <https://eesti.elu.com/et/eesti-elu/paberleht/11209-eesti-elu-nr-48-4-detsember-2020-digileht>

Ei tea mida ülikoolis õppida? Erialatest aitab teha õige valiku

postimees.ee 2023 [Ei tea mida ülikoolis õppida? Erialatest aitab teha õige valiku](#) [Ei tea mida ülikoolis õppida? Erialatest aitab teha õige valiku](#)

E-learning tools for teaching self-test of digital electronics

Jutman, Artur; Gramatova, Elena; Pikula, T.; Ubar, Raimund-Johannes 15 EAEIE International Conference on Innovation in Education for Electrical and Information Engineering : Sofia, Bulgaria, May 27-29, 2004 2004 / p. 267-272 : ill

EPPS-2 (isiksuse vajaduste struktuuri testi) kasutamise võimalustest emotsionaalse stressi uurimisel

Nõmm, Tiina; Tint, Piia Актуальные вопросы охраны труда и правовой охраны промышленной собственности 1989 / lk. 97-101

ESTEL test : tests of the English language : lower-intermediate level

Kokkota, Valmar 1999 https://www.ester.ee/record=b1056546*est

Evaluation of DOAC dipstick test for detecting direct oral anticoagulants in urine compared with a clinically relevant plasma threshold concentration

Örd, Lenna; Marandi, Toomas; Märk, Marit; Raidjuk, Leonid; Kostjuk, Jelena; Banyas, Valdas; Krause, Karit; **Pikta, Marika** Clinical and Applied Thrombosis/Hemostasis 2022 / 8 p. : ill <https://doi.org/10.1177/10760296221084307> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Evaluation of some mechanical and physical properties of 'Oriented Strand Board (OSB/3)' following cyclic accelerated aging tests

Lille, Harri; **Kiviste, Mihkel**; Telling, Renar; Leppik, Taimo; Virro, Indrek; Kask, Regino European journal of wood and wood products 2022 / p. 731-740 <https://doi.org/10.1007/s00107-022-01803-9>

Exact static compaction of independent test sequences

Raik, Jaan; Jutman, Artur; Ubar, Raimund-Johannes BEC 2002 : proceedings of the 8th Biennial Baltic Electronics Conference : October 6-9, 2002, Tallinn, Estonia 2002 / p. 315-318 : ill

Exact static compaction of sequential circuit tests using branch-and-bound and search state registration

Raik, Jaan; Jutman, Artur; Ubar, Raimund-Johannes ETW'02 : 7th IEEE European Test Workshop, Gorfou Greece, May 26-29, 2002 : informal digest 2002 / p. 19-20 https://www.researchgate.net/publication/250423148_Exact_Static_Compaction_of_Sequential_Circuit_Tests_Using_Branch_and-Bound_and_Search_State_Registration

Experimental comparison of different diagnosis algorithms in the BIST environment

Ubar, Raimund-Johannes; Kostin, Sergei; Raik, Jaan; Kruus, Margus Proceedings of the 16th IASTED International Conference on Applied Simulation and Modelling : August 29-31, 2007, Palma de Mallorca, Spain 2007 / p. 271-276 : ill https://www.researchgate.net/publication/262275431_Experimental_comparison_of_different_diagnosis_algorithms_in_the_BIST_environment

Fast and efficient static compaction of test sequences based on greedy algorithms

Raik, Jaan; Jutman, Artur; Ubar, Raimund-Johannes IEEE Design and Diagnostics of Electronic Circuits and Systems - IEEE DDECS 2001 : Fourth International Workshop on IEEE Design and Diagnostics of Electronic Circuits and Systems : Győr, Hungary, April 18-20, 2001 2001 / p. 117-122 https://slideplayer.com/slide/9971880/#google_vignette

Fast static compaction of test sequences using implications and greedy search

Raik, Jaan; Jutman, Artur; Ubar, Raimund-Johannes ETW 2001 : IEEE European Test Workshop : Stockholm, May 29 June 1, 2001 : informal digest 2001 / p. 207-209 : ill <https://www.semanticscholar.org/paper/Fast-Static-Compaction-of-Test-Sequences-using-and-Raik-Jutman/3a7a8ddda6e63d3e2fde0c8650d4518851746221>

Fault diagnosis in the BIST environment based on bisection of detected faults

Ubar, Raimund-Johannes; Kostin, Sergei; Raik, Jaan LATW2007 : 8th IEEE Latin-American Test Workshop : March 11-14, 2007, Cuzco, Peru 2007 / [6] p. : ill

Feste Wortverbindungen des Deutschen als Objekt des Testens

Umborg, Viktoria 2nd regional seminar Testing in foreign language teaching : Tallinn, February 25-26, 1986 : summaries 1986 / S. 79-81 https://www.ester.ee/record=b1217950*est

Filosoofia ja loogika e-kursuste enesetestid [Elektroonline teavik]

Meos, Indrek 2020 <https://www.indrekmeos.xyz/enesetestid.html>

Filosoofia ja loogika testid [Elektroonline teavik]

Meos, Indrek 2020 <https://filosoofia.indrekmeos.xyz/testid/>

FTGEN - система генерирования функциональных тестов

Ubar, Raimund-Johannes; Dušina, Julia; Zaugarov, Viktor; Крупнова Е.; **Storožev, Sergei** Proceedings of CAD-93 : new information technologies for science, education and business, Yalta, May 4-13, 1993 1993 / p. 123-125

Functional built-in self-test for processor cores in SoC

Ubar, Raimund-Johannes; Indus, Viljar; Kalmend, Oliver; Evertson, Teet; Orasson, Elmet 30th IEEE NORCHIP Conference : Copenhagen, Denmark, November 12-14, 2012 2012 / p. 1-4 : ill <https://ieeexplore.ieee.org/document/6403148>

Functional test program generation for digital systems

Ubar, Raimund-Johannes; Dušina, Julia; Krupnova, Helena; Storožev, Sergei; Zaugarov, Viktor Testmethoden und Zuverlässigkeit von Schaltungen und Systemen : proceedings of the 6th workshop, Vaals (Niederlande), March 6-8, 1994 1994 / p. 14-18: ill

Geneetiline test aitab arstidel määrata sobivaima ravimi ja annuse

Laanetu, Mari-Liis; Viigimaa, Margus mu.ee 2024 [Geneetiline test aitab arstidel määrata sobivaima ravimi ja annuse](https://www.ester.ee/record=b2150914*est)

Generating tests from EFSM models using guided model checking and iterated search refinement

Ernits, Juhan-Peep; Kull, Andres; Raiend, Kullo; Vain, Jüri Formal Approach to Software Testing and Runtime Verification : First Combined International Workshops FATES 2006 and RV 2006 : Seattle, WA, USA, August 15-16, 2006 : revised selected papers 2006 / p. 85-99 https://link.springer.com/chapter/10.1007/11940197_6

A global methodology for test program generation starting from high level specifications

Storojev, Sergei; Leveugle, Regis; Saucier, Gabriele BEC : Baltic Electronics Conference : proceedings of the 4th Biennial Conference, October 9-14, 1994, Tallinn (Estonia). 1 1994 / p. 305-311: ill https://www.ester.ee/record=b2150914*est

Hierarchical approaches to test generation and fault simulation

Ubar, Raimund-Johannes Radioelectronics and informatics 2003 / p. 204

Hierarchical defect level test quality analysis

Blyzniuk, M.; Cibakova, Tatiana; Gramatova, Elena; Kuzmich, W.; Lobur, M.; Pleskacz, Witold A.; **Raik, Jaan; Ubar, Raimund-Johannes** VILAB User Forum 2000 / [11] p

Hierarchical test generation based on alternative graph model

Ubar, Raimund-Johannes Proceedings of the Second Workshop on Hierarchical Test Generation : Microelectronics Technology Park, Duisburg, Germany, September 25-26, 1995 1995 / p. 18

Hierarchical test generation for complex digital systems with control and data processing parts

Ubar, Raimund-Johannes; Raik, Jaan "Test, Assembly and Packaging" : SEMICON Technical Symposium : Singapur, May 3-6, 1999 1999 / p. 43-52

Hierarchical test generation. SEMI show slides

Ubar, Raimund-Johannes; Raik, Jaan "Test, Assembly and Packaging" : SEMICON Technical Symposium : Singapur, May 3-6, 1999 1999 / p. 53-64

Hierarchical test synthesis for digital systems using alternative graph model

Ubar, Raimund-Johannes Quantitative aspects of designing and validating dependable computing systems 1995

High-level implementation-independent software-based self-test for RISC type microprocessors = Mikroprotsessorite tarkvarapõhine implementatsioonist mittesõltuv funktsionaalne enesekontroll

Oyeniran, Adeboye Stephen 2020 <https://digikogu.taltech.ee/et/Item/08a75fbb-3f71-4fe4-b3d0-3f37a9a5f36d>

High-level test synthesis with hierarchical test generation

Jervan, Gert; Eles, Petru; Peng, Zebo; **Raik, Jaan**; **Ubar, Raimund-Johannes** 17th NORCHIP Conference : Oslo, Norway, 8-9 November 1999 : proceedings 1999 / p. 291-296

HomeLabKits - implementation and usage

Jaanus, Martin; **Kukk, Vello**; **Umbleja, Kadri**; **Gordon, Boris**; **Pikkov, Mihhail** BEC 2012 : 2012 13th Biennial Baltic Electronics Conference : proceedings of the 13th Biennial Baltic Electronics Conference : October 3-5, 2012, Tallinn, Estonia 2012 / p. 331-334 : ill

Hybrid BIST scheduling for NoC-based SoCs

Jervan, Gert; **Shchenova, Tatjana**; **Ubar, Raimund-Johannes** Proceedings [of] 24th IEEE Norchip Conference : Linköping, Sweden, 20-21 November 2006 2006 / p. 141-144 : ill <https://ieeexplore.ieee.org/document/4126966>

Interrelation between word structure and types of language tests

Novikova, E.S. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 69-70

Investigation and development of test generation methods for control part of digital systems

Brik, Marina 2002 http://www.ester.ee/record=b1688656*est

Is information and communication technology satisfying educational needs at school?

Ferraro, Simona Computers & Education 2018 / p. 194-204 : ill <https://doi.org/10.1016/j.compedu.2018.04.002> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Java applets support for an asynchronous-mode learning of digital design and test

Jutman, Artur; **Sudnitsön, Aleksander**; **Ubar, Raimund-Johannes**; Wuttke, Heinz-Dietrich ITHET 2003 proceedings : 4th International Conference on Information Technology Based Higher Education and Training : July 7-9, 2003, Marrakech, Morocco 2003 / p. 397-401 : ill <https://citeseerx.ist.psu.edu/document?repid=rep1&type=pdf&doi=92f0b0e5011a2192d5a1b98baa751cb8cd2f7ff3>

Kas oskad vastata aegade keerulisima maateaduste olümpiaadi küsimustele?

postimees.ee 2022 "[Kas oskad vastata aegade keerulisima maateaduste olümpiaadi küsimustele?](#)"

Kas tead, kes on rahalehm ja millega üks FIE tegelema ei pea? Pane end proovile! [Võrguväljaanne]

postimees.ee 2022 [Kas tead, kes on rahalehm ja millega üks FIE tegelema ei pea? Pane end proovile!](#)

Kiirmeetod paberi toksilisuse määramiseks, milles testorganismidena kasutatakse fotobaktereid

Kahru, Anne; Põllumaa, Lee; **Külm, I.**; Kanger, K. EMS 96 teaduskonverents, 6.-7. juuni 1996, Tallinn = EMS 96 Scientific Conference, 6-7 June 1996, Tallinn 1996 / poster 18

Knowledge-based test generation from specifications

Tepandi, Jaak Proceedings of the Estonian Academy of Sciences. Engineering 1997 / 2, p. 127-142: ill

Kohalik vesi ja toit laboris luubi all : [TTÜ Virumaa Kolledži keemialaboris tehtud teste kommenteerivad lektor Antonina Zguro ja dotsent Larissa Grigorjeva]

Sommer-Kalda, Sirle Põhjarannik 2011 / lk. 6 : fot

Kompetentsustest : finantsarvutuste üldalused = engineering economics

1993 http://www.ester.ee/record=b4754159*est

Konstrueeritavate vastustega testi rakendamise kogemusi

Raukas, Uusi Õppemetoodika küsimusi ; 9 1972 / lk. 105-110 https://www.ester.ee/record=b1346720*est

Koroonatestideks kogutud materjalis leidub väärt infot ka teiste haigustekitajate kohta [Võrguväljaanne]

Ojamets, Indrek novaator.err.ee 2020 / fot [Koroonatestideks kogutud materjalis leidub väärt infot ka teiste haigustekitajate kohta](#)

Kuidas mõõta väsimust? TalTechi magistrant Ain-Joonas Toose kirjutas sellest lõputöö ja pakkus lahenduse

digi.geenius.ee 2023 [Kuidas mõõta väsimust? TalTechi magistrant Ain-Joonas Toose kirjutas sellest lõputöö ja pakkus lahenduse](#)

Kuidas testida juhuarve?

Võhandu, Leo Arvutustehnika ja Andmetöötlus 1991 / 9, lk. 16-22

Kuulamisosa põhjalikum analüüs. Kuulamisoskuse test 1997. a. riigieksamil

Saksa keel : riigieksam 1997 1997 / lk. 10, 32-38

KüberNööpnõel 2022 : tulemused

Lorenz, Birgy; Toom, Hanna; Talisainen, Aleksei; Baum, Anu; Eomäe, Taavi 2023

<https://docs.google.com/document/d/1hExVLGR88jwb82mBDKx3IJ2Fex7uyQjXtUbJxuJts/edit>

KüberNööpnõel 2025 tulemused

Lorenz, Birgy; Toom, Hanna; Lust, Maia; Talisainen, Aleksei 2025 [KüberNööpnõel 2025 tulemused \(Google Docs\)](#)

KüberNööpnõel tulemused 2024

Lorenz, Birgy; Toom, Hanna; Talisainen, Aleksei; Kirna, Catlyn 2024 [KüberNööpnõel tulemused 2024 \(Google Docs\)](#)

KüberPuuring 2022 analüüs : võistlus 7.-12. klassile

Lorenz, Birgy; Eomäe, Taavi; Talisainen, Aleksei; Kikas, Oliver; Muulmann, Triin 2022

https://docs.google.com/document/d/1PuBEkjrHGIMU6h9vWb_-e7eExrG3kE7aSiTGtr9vsY/edit

KüberPähkel 2022 tulemused

Lorenz, Birgy; Eomäe, Taavi; Talisainen, Aleksei; Toom, Hanna 2023 <https://docs.google.com/document/d/1MOEUsvhLjl8e9-DuYA7YRGLckC9aXx1nnx2eXPF9SUA/edit>

KüberPähkel 2024 tulemused

Lorenz, Birgy; Toom, Hanna; Kirna, Catlyn; Lust, Maia; Kits, Rasmus 2025 [KüberPähkel 2024 tulemused \(Google Docs\)](#)

Legislation of direct-to-consumer genetic testing in Europe : a fragmented regulatory landscape

Kalokairinou, Louiza; Howard, H. C.; Slokenberga, S.; Fisher, E.; Titma, Tiina Journal of community genetics 2018 / p. 117-132

<https://doi.org/10.1007/s12687-017-0344-2> [Journal metrics at Scopus](#) [Article at Scopus](#)

Letter-deletion procedure: a flexible way of reducing the text redundancy for cloze tests

Kokkotal, Valmar III Regional Seminar "Theoretical Problems of Language Testing", Tallinn, February 16-17, 1988 : summaries 1988

/ p. 51-53 : ill https://www.ester.ee/record=b1238663*est

Lühiesseed. V osa [Elektrooniline teavik]

Meos, Indrek 2020 https://filosoofia.indrekmeos.xyz/esseed_5.html

Majandusarvestuse aluste lühiülesanded ja testid

Sarapik, Jutta; Maspanov, Ivi 1999 https://www.ester.ee/record=b1222827*est

A microbiological test for nutritive value

Veskus, Tiina; Vokk, Raivo Kemia-kemi = [Finnish chemistry] 1991 / p. 949 https://www.ester.ee/record=b1201067*est

Miks peaksin olema osa grupist?

Spitsõn, Piret Studioosus 2012 / lk. 33 https://www.ester.ee/record=b1558644*est

Mis loom see isiksus veel on?

Spitsõn, Piret Studioosus 2012 / lk. 26-27 https://www.ester.ee/record=b1558644*est

Mis on head ja halba Bioestis? : [prof. Anti Viikna TTÜ teadlaste korraldatud testist]

Viikna, Anti; Luts, Eva Postimees 1996 / 12. nov., Kasu, lk. 3

Mixed-level test generator for digital systems

Brik, Marina; Jervan, Gert; Markus, Antti; Paomets, Priidu; Raik, Jaan; Ubar, Raimund-Johannes Proceedings of the Estonian Academy of Sciences. Engineering 1997 / 4, p. 271-282 : ill

Multi-purpose cyber environment for maritime sector

Visky, Gabor; Lavrenovs, Arturs; Orye, Erwin; Heering, Dan; Tam, Kimberly Proceedings of the 17th International Conference on Cyber Warfare and Security State University of New York at Albany Albany, New York, USA 17-18 March 2022 2022 / p. 349-257

<https://doi.org/10.34190/icws.17.1.26>

New test design techniques for fault detection in digital objects

Alango, Villem; Kont, Toomas; Ubar, Raimund-Johannes Tallinna Tehnikaülikooli Toimetised 1990 / lk. 45-62: ill

Parkinson's disease diagnostics based on the analysis of digital sentence writing test

Netšunajev, Aleksei; Nõmm, Sven; Toomela, Aaro; Medijainen, Kadri; Taba, Pille Vietnam journal of computer science 2021 / p. 493-512 <https://doi.org/10.1142/S2196888821500238> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Pesupulbritesti võitis Ariel : [Tallinna Tehnikaülikoolis tehtud laboriuuringus testiti pesupulbreid]

Power-constrained hybrid BIST test scheduling in an abort-on-first-fail test environment

He, Zhiyuan; **Jervan, Gert**; Peng, Zebo; Eles, Petru Proceedings : DSD'2005 : 8th Euromicro Conference on Digital System Design : Architectures, Methods and Tools : Porto, Portugal, August 30 - September 3, 2005 2005 / p. 83-86 : ill
<https://ieeexplore.ieee.org/document/1559782>

Problemorientierte linguistische Software und rechnergeführte Testung des fremdsprachigen Rezipienten

Dolenko, L.; Tomasewitsch, N. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 30-31

Prognostic tests and their importance for the foreign language learning

Shuleshko, N. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 96

Põhilised vea- ja keele sisseastumistestides (1995. a.)

Lepp, Maie Tehnikaülikool 1996 / 19. jaan., lk. 4

Põhja-Ameerika ülikoolide teabekeskuse teatab : [TOEFEL testid 1995/96]

Teder, Eha Tehnikaülikool 1995 / 17. mai, lk. 4-5

Rahvusvaheline test keerab lahti välismaise ülikooli ukseid

Teder, Eha Eesti Päevaleht 2003 / 10. veebr., lk. 13 <https://epl.delfi.ee/artikkel/50946371/rahvusvaheline-test-keerab-lahti-valismaise-ulikooli-ukseid>

Rationale for the test of English as a foreign language

Visochinsky, Y. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 107-108

Reaalharidusest füüsiku pilgu läbi

Kalda, Jaan Sirp 2013 / lk. 16-17 <https://www.sirp.ee/s1-artiklid/c9-sotsiaalia/2013-11-14-17-20-15/>

Reactive testing of nondeterministic systems by test purpose-directed tester

Vain, Jüri; Kull, Andres; Käärmees, Marko; Markvardt, Maili; Raiend, Kullo Model-based testing for embedded systems 2012 / p. 425-452 : ill https://www.researchgate.net/publication/234117187_Reactive_Testing_of_Nondeterministic_Systems_by_Test_Purpose-Directed_Tester

Reostatud pinnase suhtelise toksilisuse määramine fotobakteritestidega

Reiman, Rain; Kahru, Anne; Põllumaa, Lee; Meriste, T. Eesti Mikrobioloogide Ühenduse konverents : 12.05.2000, Tartu = Conference of the Estonian Society for Microbiology : 12.05.2000, Tartu 2000 / l. 14

Replication-based deterministic testing of 2-dimensional arrays with highly interrelated cells

Azad, Siavoosh Payandeh; Oyeniran, Adeboye Stephen; Ubar, Raimund-Johannes 21st IEEE International Symposium on Design and Diagnostics of Electronic Circuits and Systems : DDECS 2018 : Budapest, Hungary 25-27 April, 2018 : proceedings 2018 / p. 21-26 : ill <https://doi.org/10.1109/DDECS.2018.00011>

Riiklik saksa keele eksam "Abitur-Deutsch 1995-1998" : eksperiment saksa keele riikliku eksami rakendamiseks Eesti keskkoolides ja gümnaasiumides : käsiraamat

1997 https://www.ester.ee/record=b1054047*est

School-level policies and the efficiency and equity trade-off in education

Ferraro, Simona; Pöder, Kaare Journal of policy modeling 2018 / 16 p. : ill <https://doi.org/10.1016/j.jpolmod.2017.11.001> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Sentence writing test for Parkinson disease modeling: comparing predictive ability of classifiers

Netšunajev, Aleksei; Nömm, Sven; Toomela, Aaro; Medijainen, Kadri; Taba, Pille Intelligent Information and Database Systems : 12th Asian Conference, ACIIDS 2020, Phuket, Thailand, March 23-26, 2020 : proceedings, Part I 2020 / p. 345-357
https://doi.org/10.1007/978-3-030-41964-6_30 [Conference proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

SoC and board modeling for processor-centric board testing

Tšertov, Anton; Ubar, Raimund-Johannes; Jutman, Artur; Devadze, Sergei 14th Euromicro Conference on Digital System Design : Architectures, Methods and Tools : DSD 2011 : 31 August - 2 September 2011, Oulu, Finland : proceedings 2011 / p. 575-582 : ill <https://ieeexplore.ieee.org/document/6037463>

Software for improving the efficiency of test filtration tasks

Häkkinen, Antti; Huhtanen, Mikko; Ekberg, Bjarne; **Kallas, Juha** 22nd Annual American Filtration & Separations Society Conference : Bloomington, MN, May 4-7, 2009 2009 / ? p

SPEC92 jõudlustesti vahetab välja SPEC95

Toomsalu, Arvo Arvutustehnika ja Andmetöötlus 1996 / 2, lk. 6-8

Standardization of English achievement test series ATU

Einväli, E.; Kokkota, Valmar; Toomsalu, Marju; Truu, Sirje; Tšetörkina, Ene; Volgina, Olga; Võrk, Evi-Mai III Regional Seminar

"Theoretical Problems of Language Testing", Tallinn, February 16-17, 1988 : summaries 1988 / p. 31-34

https://www.ester.ee/record=b1238663*est

Standardization of foreign language tests series ITA

Einväli, E.; Kokkota, Valmar; Kukk, Helja-Amanda; Toomsalu, Marju; Tšetörkina, Ene; Volgina, Olga; Võrk, Evi-Mai 2nd

regional seminar Testing in foreign language teaching : Tallinn, February 25-26, 1986 : summaries 1986 / p. 32-35

https://www.ester.ee/record=b1217950*est

Standardized English language achievement test : ITA-84 form A-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304725*est

Standardized English language achievement test : ITA-84 form A-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304710*est

Standardized English language achievement test : ITA-84 form B-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304777*est

Standardized English language achievement test : ITA-84 form B-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304782*est

Standardized English language achievement test : ITA-84 form C-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304791*est

Standardized English language achievement test : ITA-84 form C-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304793*est

Standardized English language general proficiency (cloze) test : ITA-84-KT form A-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304709*est

Standardized English language general proficiency (cloze) test : ITA-84-KT form A-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304731*est

Standardized English language general proficiency (cloze) test : ITA-84-KT form B-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304799*est

Standardized english language general proficiency (cloze) test : ITA-84-KT form B-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304802*est

Standardized English language general proficiency (cloze) test : ITA-84-KT form C-1

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304805*est

Standardized english language general proficiency (cloze) test : ITA-84-KT form C-2

Kokkota, Valmar 1985 https://www.ester.ee/record=b5304808*est

Standardized test ITA-83 questionnaire data

Kokkota, Valmar; Uibo, Mari 2nd regional seminar Testing in foreign language teaching : Tallinn, February 25-26, 1986 : summaries

1986 / p. 53-54 https://www.ester.ee/record=b1217950*est

Stress - mis see on?

Spitsõn, Piret Studioosus 2012 / lk. 26-27 https://www.ester.ee/record=b1558644*est

Students' individual psychological features and their test results

Sereda, G.; Ivanova, O. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries

1991 / p. 91-92

A study the toxicity of the ozonation products of phenols and cholorophenols by Daphnia magna test

Trapido, Marina; Veressinina, Jelena; Munter, Rein Proceedings of the Estonian Academy of Sciences. Chemistry 1997 / p. 130-139: ill

Supernõunik Mario Kadastik: suurim viga on mitte otsustada

Tiks, Joosep Eesti Ekspress 2021 / lk. 4 : joon <https://dea.digar.ee/article/eestiekspress/2021/11/17/5.1>

Suvekool: kui selle rohetesti vastustest poolele pihta saad, on isegi hästi läinud!

digi.geenius.ee 2024 [Suvekool: kui selle rohetesti vastustest poolele pihta saad, on isegi hästi läinud!](#)

Suvekool: testi oma teadmisi merenduses

digi.geenius.ee 2024 [Suvekool: testi oma teadmisi merenduses](#)

Südameasjad

Lemba, Maris; Kongas, Olav; Vendelin, Marko Noored teaduses 2000 / lk. 62-66 : portr https://artiklid.elnet.ee/record=b2111022*est

System of tests in contemporary foreign language syllabus

Rumpite, D. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 82-85

Zum Problem der linguistischen Lernfähigkeiten als Testobjekt

Ejger, G.W.; Rapoport, I.A. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 33-36

Tallinna Polütehnilisse Instituuti 1972. aastal vastu võetud üliõpilaskontingendi testitulemuste analüüs

Lõhmus, Ahto; Nugis, E.; Saar, H. Õppemetoodika küsimusi ; 10 1973 / lk. 125-130 : ill., tab

https://www.ester.ee/record=b1346720*est

Tallinna Tehnikaülikool ja Synlab Eesti alustasid koostööd kliiniliste kiirtestide väljaarendamiseks

Mente et Manu 2021 / lk. 13 [Mente et Manu 1/2021](#) https://www.ester.ee/record=b1242496*est

TalTechi erialatestist saab endale sobiva eriala kohta vastuse kümne minutiga

postimees.ee 2023 [TalTechi erialatestist saab endale sobiva eriala kohta vastuse kümne minutiga](#)

TalTechi inseneeria test [Võrguväljaanne]

postimees.ee 2021 ["TalTechi inseneeria test"](#)

TalTechi majandusteadmiste test [Võrguväljaanne]

postimees.ee 2021 ["TalTechi majandusteadmiste test"](#)

TalTechi õigusteadmiste test [Võrguväljaanne]

postimees.ee 2021 ["TalTechi õigusteadmiste test"](#)

"Tervis ruudus", ehk, Tippkeskuse CEBE lugu

Ubar, Raimund-Johannes Teadusmõte Eestis (X). Tehnikateadused. 3 : [artiklikogumik] 2019 / lk. 200-215 : ill., fot

https://www.ester.ee/record=b5208765*est

A test bench to study propulsion drives of electric vehicles [Electronic resource]

Rassõlkin, Anton; Vodovozov, Valery CPE 2013 : 2013 International Conference on Compatibility and Power Electronics (CPE) : June 5-7, 2013, Ljubljana, Slovenia : conference proceedings 2013 / p. 275-279 : ill [CD-ROM]

A test bench to study propulsion drives of electric vehicles with a supercapacitor storage system [Electronic resource]

Rassõlkin, Anton; Vodovozov, Valery Международная Научно-Техническая Конференция "Силовая Электроника и Энергоэффективность" : 23-27.IX 2013, Алушта, Крым 2013 / [3] p. : ill [CD-ROM]

Test development and deployment tool-set for mixed-signal and digital devices

Mellik, Andres; Raik, Jaan BEC 2008 : 2008 International Biennial Baltic Electronics Conference : proceedings of the 11th Biennial Baltic Electronics Conference : Tallinn University of Technology : October 6-8, 2008, Tallinn, Estonia 2008 / p. 163-166 : ill

Test für praktische deutsche Grammatik

Lomakina, Valentina 1987 https://www.ester.ee/record=b2170574*est

Test generation with structurally synthesized BDD models

Raik, Jaan; Ubar, Raimund-Johannes Proceedings of the 5th Electronic Devices and Systems Conference, Brno, June 11-12, 1998 1998 / p. 66-68

Test synthesis with alternative graphs

Ubar, Raimund-Johannes IEEE design & test of computers 1996 / Spring, p. 48-57: ill

TEST: Gümnaasiumi maateaduse olümpiaadi küsimused [Võrguväljaanne]

postimees.ee 2021 ["TEST: Gümnaasiumi maateaduse olümpiaadi küsimused"](#)

TEST: Kui hästi tunned meditsiinitehnoloogiat? [Võrguväljaanne]

postimees.ee 2021 ["TEST: Kui hästi tunned meditsiinitehnoloogiat?"](#)

TEST: Kui palju tead energeetikast? [Võrguväljaanne]

postimees.ee 2021 ["TEST: Kui palju tead energeetikast?"](#)

Testid harjutamiseks

Teichmann, Mare; Anton, Riina 1997

Testieren der kommunikativen Sprachkompetenz

Serwuta, A. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 92-94

Testing and evaluation of students' activity results in interconnected acquiring of a foreign language and professional subjects in a higher technical school

Rotanova, A. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 80-82

Testing and implementation of mobile services for packet-based networks

Kulmar, Marika; Ots, Avo; Tomingas, Peep Baltic ITAMPT review 2002 / 3, p. 32-34 : ill https://artiklid.elnet.ee/record=b2024795*est

Testing and teaching

Spolsky, Bernard V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 97-98

Testing as a means of consolidation of students' knowledge

Shaymardanova, Sh.Kh. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 94-95

Testing English for specific purposes

Tsurova, I. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 100-102

Testing foreign language proficiency

Andreyeva, I.V.; Akhtyamova, F.A.; Khvesina, M.V. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 8-10

Testing of 2048 kbit/s digital structured leased line frame structure

Kravets, Valeri Telekommunikatsioon '98 : rahvusvahelise telekommunikatsioonipäeva konverentsi ettekannete materjalid, 15. mai 1998 1998 / lk. 60-65: ill

Testing tools for training and education

Balaž, M.; Jutman, Artur; Raik, Jaan; Ubar, Raimund-Johannes Proceedings of the 12th International Conference : Mixed Design of Integrated Circuits and Systems : MIXDES 2005 : Krakow, Poland, 22-25 June, 2005. Vol. 1 of 2 2005 / p. 671-676 : ill

Tests as a means of controlling the formation and development of the learner's target language system

Dostovalova, I. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 31-33

Tests at English lessons

Proshkina, V. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 73-74

Tests in a teaching process at a foreign-language department of technical institutes : (some practical results of Sevastopol Machine Engineering Institute)

Abrosimova, L.; Shumilina, T. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 6-8

Tests in teaching basic course

Bryzgalova, V.G.; Dracheva, G.I. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 15-16

Testsystem als Grundlage für die Individualisierung bei Erlernung der Fremdsprachen

Jemeljanov, J. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 55-56

The application of multiple-choice technique of half-open type

Dadykina, N.; Layenko, L. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 24-25

The didactical and pedagogical advantages of testing in computer assisted language learning (CALL)

Ilyinskaja, L.; Lasmane, B.; Vevere, I. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 49-51

The perspective of microbiotests application in water monitoring system in Estonia

Blinova, Irina 9th International Symposium on Toxicity Assessment : ISTA 9 : Pretoria, South Africa, 26 September to 1 October 1999 : programme and abstracts 1999 / p. 7

The role of semantic ties in cloze-type item-solving strategy

Kokkoto, Valmar III Regional Seminar "Theoretical Problems of Language Testing", Tallinn, February 16-17, 1988 : summaries 1988 / p. 54-56 https://www.ester.ee/record=b1238663*est

The system of language testing at Lvov Polytechnic Institute

Belyakevich, I.I.; Knjazevsky, B.N.; Savenko, O.M. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 10-12

The test application and results among the naval cadets of the Caspian Naval College

Uchaikina, I. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 102-104

The use of control tests at the medical institutes

Danilov, B.S.; Cunitscaya, N.V. V Regional Seminar East-West meeting of language testing, Tallinn, Sept. 2-4, 1991 : summaries 1991 / p. 25-26

The wear resistance tests of cermets and relations between different types of wear

Joost, Renee; Letunovitš, Sergei; Pirso, Jüri; Juhani, Kristjan Proceedings of 14th Nordic Symposium on Tribology : NORDTRIB 2010 : 08.06-11.06.2010, Storforsen, Sweden 2010 / [6] p.: ill. [CD-ROM]

Thesen des Vortrags "Die Überprüfung der Hauslektüre mit Testmethode"

Jefimowa, N.; Slessarewa, J. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 52-54

TOEFL-test - milleks valmistuda?

Kirss, Epp Õpetajate Leht 2015 / lk. 11 <https://opleht.ee/2015/04/toefl-test-milleks-valmistuda/>

TOEFL-test avab ukseid välismaa koolidesse : [Eha Teder jagab soovitusi seoses keeletestiga]

Rebane, Mari; Teder, Eha Eesti Päevaleht 2003 / 14. nov., lk. 17 : ill

Towards a unified model for test and design quality

Aas, Einar J. BEC'96 : the 5th Biennial Baltic Electronics Conference, October 7-11, 1996, Tallinn, Estonia : proceedings 1996 / p. 17-20: ill

Toxicity of 39 MEIC chemicals to bioluminescent Photobacteria (the BiotoxTM test) : correlation with other test systems

Kahru, Anne; Borchardt, Barbara ATLA 1994 / p. 147-160

TPI I kursuse üliõpilaste inglise keele oskuse uurimine testi abil

Kokkoto, Valmar Õppemetoodika küsimusi ; 13 1976 / lk. 60-64 https://www.ester.ee/record=b1346720*est

TTÜ teadlaste loodud koroonakiirtest võib tulemuse anda pea 15 minutiga

Ojamets, Indrek novaator.err.ee 2020 / fot [TTÜ teadlaste loodud koroonakiirtest võib tulemuse anda pea 15 minutiga](#)

Turumajandusaluste kompetentsustest : üldteoreetilised teadmised

1993 https://www.ester.ee/record=b2686567*est

Using Tabu search method for optimizing the cost of hybrid BIST

Kruus, Helena; Ubar, Raimund-Johannes; Jervan, Gert; Peng, Z. XVI Conference on Design of Circuits and Integrated Systems : Porto, Portugal, 2001 2001 / p. 445-450 <https://citeseerx.ist.psu.edu/document?repid=rep1&type=pdf&doi=e97bb394ff71aa0affcc5fb372404bbc246888a8>

Using tests in "The survival course for specific purposes"

Dadykina, N. V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries 1991 / p. 23-24

Uus Tallinna Ülikooli tekkel pani testi kinni : [Üliõpilasleht testis tekkeid, ka TTÜ oma]

Boikov, Siim Üliõpilasleht 2006 / 3. apr., lk. 4

V Regional Seminar East-West Meeting of Language Testing, Tallinn, September 2-4, 1991 : summaries

1991 https://www.ester.ee/record=b1257906*est

Valikvastustega küsimustikest ja nende rakendamisest

Jaagus, Mihkel Õppemetoodika küsimusi ; 8 1971 / lk. 54-64 : tab https://www.ester.ee/record=b1346720*est

Valikvastustega testide kasutamise kogemusi õppeaines "Elektrotehnika teoreetilised alused"

Rannu, Lembit Õppemetoodika küsimusi ; 8 1971 / lk. 51-53 : joon https://www.ester.ee/record=b1346720*est

Web-based training system for teaching digital design and test

Devadze, Sergei 7th International Student Conference on Electrical Engineering : POSTER2003 : May 22, 2003, Prague, Czech Republic 2003 / p. IC6

Verification of the test quality

Matrosova, Anjela; Bochun, Tatiana BEC'96 : the 5th Biennial Baltic Electronics Conference, October 7-11, 1996, Tallinn, Estonia : proceedings 1996 / p. 307-310: ill

VIF-test : vorm M

1994

VILAB test generation tools running under the MOSCITO system

Schneider, Andre; Ivask, Eero; Raik, Jaan; Ubar, Raimund-Johannes VILAB User Forum : Győr, Hungary, 2001 2001 / [12] p

Õpilastele tarnib kiirteste uus firma

Hussar, Karoliina Eesti Päevaleht 2021 / Lk. 7 <https://dea.digar.ee/article/eestipaevaleht/2021/11/24/7.5>

Алгоритм генерирования тестов для комбинационных логических схем

Pall, I.; Ubar, Raimund-Johannes XX студенческая научно-техническая конференция вузов Прибалтийских республик, Белорусской ССР и Молдавской ССР : тезисы докладов. Часть 1 1974 / с. 133 https://www.ester.ee/record=b1306141*est

Анализ полноты тестов для цифровых схем на модели альтернативных графов

Kitsnik, Peeter Синтез и диагностика цифровых устройств и систем 1982 / с. 39-51 : илл https://www.ester.ee/record=b1328194*est
<https://digikogu.taltech.ee/et/Item/febd586e-d7fa-4fbd-bf41-40576a75f94b>

Генерация тестов для декларативных компонентов объектно-ориентированных систем с продуктами

Terandi, Jaak Объектно-ориентированное программирование : всесоюз. конф. "Актуальные проблемы системного программирования", Таллинн, 16-18 янв. 1990 1990 / с. 49-51

Генерирование операндов при синтезе тестов для микропроцессоров

Toomsalu, Arvo; Ubar, Raimund-Johannes Синтез и диагностика цифровых устройств и систем 1982 / с. 63-73 : илл

https://www.ester.ee/record=b1328194*est <https://digikogu.taltech.ee/et/Item/febd586e-d7fa-4fbd-bf41-40576a75f94b>

Генерирование тестов для микропроцессорных БИС

Viilup, Agu; Evarson, Teet Расчет и проектирование систем технической кибернетики 1983 / с. 121-129 : ил

https://www.ester.ee/record=b1288991*est <https://digikogu.taltech.ee/et/Item/7d7515af-76b7-4d35-89a7-e80367d5b635>

Дополнительные показатели качества языковых тестов

Kokkota, Valmar Тезисы докладов II зонального совещания заведующих кафедрами иностранных языков неязыковых факультетов и вузов Эстонской ССР, Белорусской ССР, Латвийской ССР, Литовской ССР и Калининградской области : Тарту, (4-7 мая 1977 г.) 1977 / с. 51-53 https://www.ester.ee/record=b1317941*est

Использование обучающих тестов в условиях применения ЭВМ

Alver, Jaan; Ots, Lehte Опыт применения новых методов и технических средств обучения : тезисы докладов VII Региональной научно-методической конференции преподавателей вузов Прибалтики, Белорусской ССР и Калининградской обл. РСФСР 1990 / с. 153-154

Использование тестов Клоуч при организации самостоятельной работы студентов

Kokkota, Valmar Сборник тезисов конференции : Самостоятельная работа студентов в профессионально-ориентированных обучении иностранным языкам 1990 / с. 134-137

Исследование качества лексических тестов по английскому языку

Kokkota, Valmar Вопросы преемственности курсов иностранного языка средней и высшей школы 1979 / с. 92-99

Исследование качества разных тестов исходного уровня по английскому языку

Kokkota, Valmar Вопросы преемственности в преподавании иностранных языков в вузау и средней школе 1982 / с.?

Исследование новых методов количественной оценки повседневного утомления на производстве

Kristjuhan, Ülo Актуальные вопросы охраны труда и правовой охраны промышленной собственности 1985 / с. 45-50

Исследование разных видов клоуз-тестов

Kokkota, Valmar Лингвистические и методические вопросы обучения разным видам речевой деятельности и проблемы тестирования 1981 / с. 40-45 https://www.ester.ee/record=b1715279*est

Исследование форм предъявления лексических единиц в тесте исходного уровня

Murumets, S.; Vörk, Evi-Mai; Kokkota, Valmar Тезисы докладов II зонального совещания заведующих кафедрами иностранных языков неязыковых факультетов и вузов Эстонской ССР, Белорусской ССР, Латвийской ССР, Литовской ССР и Калининградской области : Тарту, (4-7 мая 1977 г.) 1977 / с. 82-84 https://www.ester.ee/record=b1317941*est

Какие ДНК-тесты можно сделать в Эстонии и насколько они достоверны [Online resource]

mke.ee 2021 ["Какие ДНК-тесты можно сделать в Эстонии и насколько они достоверны"](#)

Какие ДНК-тесты можно сделать в Эстонии и насколько они достоверны [Online resource]

Kjutšjuk, Svetlana rus.delfi.ee 2021 ["Какие ДНК-тесты можно сделать в Эстонии и насколько они достоверны"](#)

Метод алгоритмического генерирования тестов при контроле цифровых схем

Grigorjeva, Ksenja; Lohuaru, Tõnu; Evertson, Teet Синтез и диагностика цифровых устройств и систем 1982 / с. 75-83 : илл https://www.ester.ee/record=b1328194*est <https://digikogu.taltech.ee/et/Item/febd586e-d7fa-4fbd-bf41-40576a75f94b>

Метод построения парных диагностических тестовых последовательностей для последовательностных схем

Grigorjeva, Ksenja Расчет и проектирование приборов, устройств и систем технической кибернетики 1980 / с. 21-30 : илл https://www.ester.ee/record=b1264145*est <https://digikogu.taltech.ee/et/Item/81bf2178-a9f8-417d-86c7-2000cca6a01e>

Некоторые вопросы составления контрольных тестов и определения их надежности

Alver, Jaan; Ярве В.И. Опыт применения новых методов и технических средств обучения : тезисы докладов VII Региональной научно-методической конференции преподавателей вузов Прибалтики, Белорусской ССР и Калининградской обл. РСФСР 1990 / с. 80-82

О мощности тестов

Lõhmus, Ahto Аннотации докладов и выступлений участников Второго совещания-семинара преподавателей математики вузов Белорусской, Латвийской, Литовской, Эстонской ССР и Калининградской области 1973 / с.48-49 https://www.ester.ee/record=b1568235*est

О результатах дедуктивного анализа тестов в комбинационных схемах

Kitsnik, Peeter Анализ и моделирование технических устройств и систем АСУТП 1977 / с. 25-29 : илл https://www.ester.ee/record=b2190987*est <https://digikogu.taltech.ee/et/Item/b7c66054-0b4f-4684-9453-442bc7e6e200>

О снижении комбинаторных трудностей при синтезе тестов для цифровых автоматов

Ubar, Raimund-Johannes Расчет и проектирование систем технической кибернетики 1983 / с. 111-119 : ил https://www.ester.ee/record=b1288991*est <https://digikogu.taltech.ee/et/Item/7d7515af-76b7-4d35-89a7-e80367d5b635>

Об автоматическом синтезе тестов для цифровых объектов систем управления

Plakk, Mari; Ubar, Raimund-Johannes VII Всесоюзное совещание по проблемам управления, Минск, 21-25 ноября 1977. Кн. 3 1977 / с. 97-98

Об использовании обучающих тестов в условиях применения ЭВМ

Alver, Jaan; Отс Л.А. Опыт применения новых методов и технических средств обучения : тезисы докладов VII Региональной научно-методической конференции преподавателей вузов Прибалтики, Белорусской ССР и Калининградской обл. РСФСР 1991 / с. 46-47

Об экономичности тестов по иностранному языку

Kokkota, Valmar Иностранные языки в высшей школе : республиканский межвузовский сборник научных трудов 1973 / с. 113-120

Обобщенная модель альтернативных графов для синтеза тестов цифровых систем

Ubar, Raimund-Johannes Расчет и проектирование систем технической кибернетики 1983 / с. 97-109 : ил

https://www.ester.ee/record=b1288991*est <https://digikogu.taltech.ee/et/Item/7d7515af-76b7-4d35-89a7-e80367d5b635>

Описание ЦВМ моделью векторных альтернативных графов с целью синтеза диагностических микропрограмм
Ubar, Raimund-Johannes Расчет и проектирование приборов, устройств и систем технической кибернетики 1980 / с. 11-20 : илл https://www.ester.ee/record=b1264145*est <https://digikogu.taltech.ee/et/Item/81bf2178-a9f8-417d-86c7-2000cca6a01e>

Пластично-вязкие свойства теста на гипсоцементно-пуццолановом вяжущем с добавками
Saharov, G. P.; Gorbunov, G.; **Gordon, Boris**; Tšernõševa, N. Реология бетонных смесей и ее технологические задачи : тезисы докладов VI всесоюзного симпозиума, г. Рига, 5-7 декабря 1989 г 1989 / с. 99-101 https://www.ester.ee/record=b2448356*est

Построение полных контролирующих тестов комбинационных схем
Ubar, Raimund-Johannes Eesti NSV Teaduste Akadeemia toimetised. Füüsika. Matemaatika = Известия Академии наук Эстонской ССР. Физика. Математика = Proceedings of Academy of Sciences of the Estonian SSR. Physics. Mathematics 1982 / lk. 418-427; ill. https://www.ester.ee/record=b1264310*est

Построение проверяющего теста для сети автоматов
Keevallik, Andres; Kasirova, Lilia; Kruus, Margus Tallinna Tehnikaülikooli Toimetised 1990 / lk. 3-19: ill

Построение тестов цифровых схем при помощи модели Альтернативных графов
Plakk, Mari; Ubar, Raimund-Johannes Автоматика и телемеханика 1980 / с. 152-163 : илл https://www.ester.ee/record=b1515055*est

Применение модели альтернативных графов при синтезе тестов для комбинационных схем
Plakk, Mari; Ubar, Raimund-Johannes Анализ и моделирование технических устройств и систем АСУТП 1977 / с. 3-13 : илл https://www.ester.ee/record=b2190987*est <https://digikogu.taltech.ee/et/Item/b7c66054-0b4f-4684-9453-442bc7e6e200>

Проектирование контрольных экспериментов в автоматизированной системе контроля цифровых автоматов "НАКС"
Voolaine, Andrus; **Jõgi, Aksel**; Pall, Martin Синтез и диагностика цифровых устройств и систем 1982 / с. 3-21 : илл https://www.ester.ee/record=b1328194*est <https://digikogu.taltech.ee/et/Item/febd586e-d7fa-4fbd-bf41-40576a75f94b>

Решение задач проектирования тестов микросистемных устройств при помощи АГ
Ubar, Raimund-Johannes Тезисы докл. всесоюзн. школы-семинара "Диагностика, надежность контроль" 1990 / с. 65

Синтез тестов для цифровых схем
Plakk, Mari; Ubar, Raimund-Johannes XIV областная научно-техническая конференция по системам и средствам управления (май 1978 г.) : тезисы докладов 1978 / с. 78-79

Система генерирования тестов для микропроцессоров
Ubar, Raimund-Johannes; Dušina, Julia; Zaugarov, Viktor; Крупнова Е.; **Storožev, Sergei** Proceedings of international conference "Technical Diagnostics-93", St.-Peterburg, June 8-10, 1993 1993 / p. 87-89

Сотрудничество по тестированию в КПИ, РПИ и ТПИ
Kokkota, Valmar Тезисы докладов II зонального совещания заведующих кафедрами иностранных языков неязыковых факультетов и вузов Эстонской ССР, Белорусской ССР, Латвийской ССР, Литовской ССР и Калининградской области : Тарту, (4-7 мая 1977 г.) 1977 / с. 53-55 https://www.ester.ee/record=b1317941*est

Стандартизация теста исходного уровня по английскому языку в вузах ЭССР
Kokkota, Valmar Лингвистические и методические вопросы преподавания иностранных языков в вузе и школе 1979 / с. 55-65 https://www.ester.ee/record=b1276076*est

Табличный способ синтеза тестов для комбинационных блоков
Plakk, Mari Расчет и проектирование приборов, устройств и систем технической кибернетики 1980 / с. 31-39 : илл https://www.ester.ee/record=b1264145*est <https://digikogu.taltech.ee/et/Item/81bf2178-a9f8-417d-86c7-2000cca6a01e>

Трансляция выходных реакций многовыходного модуля
Plakk, Mari Расчет и проектирование приборов, устройств и систем технической кибернетики 1981 / с. 63-72 : илл https://www.ester.ee/record=b1319172*est <https://digikogu.taltech.ee/et/Item/4c9b1559-97b9-4d9b-bac8-6c40840ba442>

Уровневые тесты для 9-го класса русских школ в 1997 году
Org, Helgi; Oruste, Elle; Paavo, Laine; Palm, Mari-Ann; Reppo, Kersti; **Veskimeister, Rutt** Пособие по немецкому языку 1999 / с. 138-147

Уровневые тесты для 9-го класса эстонских школ в 1997 году
Org, Helgi; Oruste, Elle; Paavo, Laine; Palm, Mari-Ann; **Veskimeister, Rutt** Пособие по немецкому языку 1999 / с. 128-138

Фактор времени в языковых тестах

Kokkota, Valmar; Võrk, Evi-Mai Исследования по методике преподавания иностранных языков 1978 / с. 41-49
https://www.ester.ee/record=b1314236*est

Формулы для дедуктивного анализа тестов в синхронных последовательностных схемах

Kitsnik, Peeter; Ubar, Raimund-Johannes Анализ и моделирование технических устройств и систем АСУТП 1977 / с. 15-23 :
илл https://www.ester.ee/record=b2190987*est <https://digikogu.taltech.ee/et/Item/b7c66054-0b4f-4684-9453-442bc7e6e200>

Что гены расскажут [Online resource]

Кjutšjuk, Svetlana МК-Эстония : самый читаемый еженедельник страны МК-Estonia 2021 / с. 18-19 ["Что гены расскажут"](#)